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4. D. L. Rogers *et al.*, "Design, fabrication & automated testing of 32 channel integrated MSM/MESFET OEIC receiver ar-rays," in *Proc. on Integrated Opto-electronics*, IEEE/LEOS 1994, pp. 3–4.

FC5   9:30 am

System performance of a 4-channel PHASAR WDM receiver operating at 1.2 Gbit/s

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Phased arrays are important key components in wavelength-division multiplexing (WDM) systems.[1] We have realized a 4-channel WDM receiver combining a phased array with pho-todetectors on InP with a Si bipolar transimpedance amplifier.[2] The channels are spaced at 2.0 nm with a 1.0-nm flat passband.[3] On chip loss was 6-7 dB and detector efficiency was better than 90%. The optical cross talk remains below −20 dB. The elec-trical bandwidth per channel was 1 GHz. The electrical cross talk at 1 GHz after detection is below −25 dB. We have tested this receiver in a full 4-channel system.

Figure 1 shows the diagram of the experimental setup. Three DFB lasers and one tunable laser were used as trans-mitters. The lasers were tuned to match the optical transmis-sion windows of the WDM receiver: 1532.1, 1534.1, 1536.1, and 1538.0 nm. Two external modulators (on/off ratio 13 dB) were used, one for the signal channel, the other one for the interfer-ing channels. A PRBS of $2^7 - 1$ was used. As our receiver was not polarization independent, polarization controllers were used to adjust the light towards TE-polarization at the input of the WDM receiver. The power levels of both were adjusted by attenuators. The combined channels were preamplified by an erbium-doped fiber amplifier (EDFA) and coupled into the re-
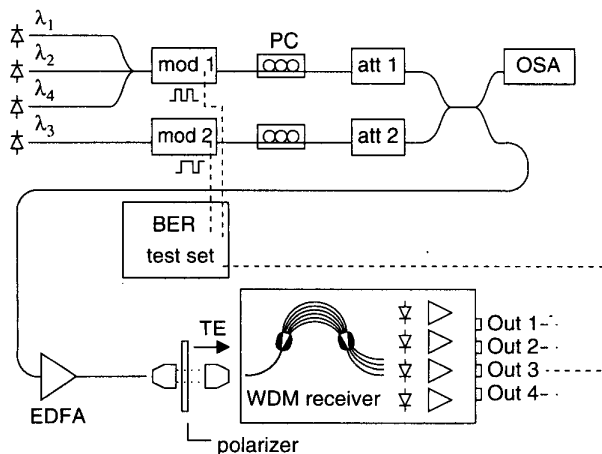
FC5 Fig. 1. Experimental setup for 4-channel WDM experiment.
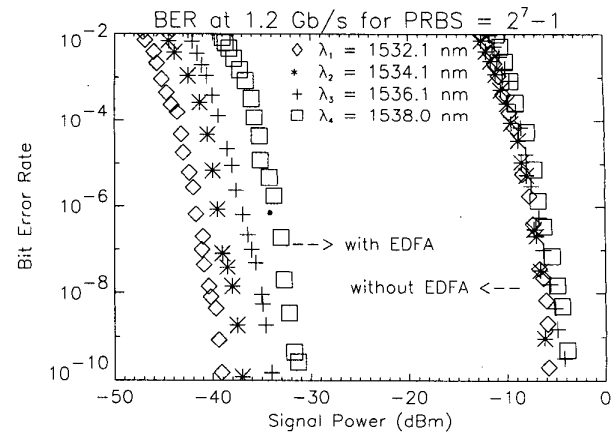
FC5 Fig. 2. Sensitivity measurements of the 4-channels with and without optical preamplification.
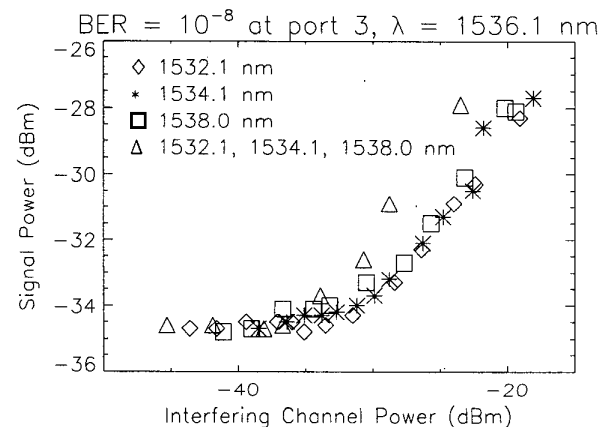
FC5 Fig. 3. Influence of interfering channels on sensitivity of channel 3. Similar figures were obtained for the other three channels.

ceiver chip by a lens system. A polarizer filtered residual TM-polarization. The electric signal was amplified, filtered by a 1-GHz low pass filter, and directed to the BER detector. No wavelength stabilization was needed, due to the flattened wavelength response (1 dB within 1.0 nm) of the demultiplexer.

Figure 2 shows the BER measurements for the four chan-nels, without interfering channels. BER curves were measured with and without optical preamplification. The WDM receiver sensitivity, between −6 and −4 dBm, was determined by the coupling losses and the noise of the transimpedance receiver. A best preamplified receiver sensitivity of −39.5 dBm was mea-sured. The differences in receiver sensitivity between the four channels was caused by the nonflat EDFA gain, because the EDFA gain was not sufficient to overcome the WDM receiver noise.

Figure 3 shows the influence of the interfering channels for port 3. The penalty curves were measured by adjusting both power levels of signal and interfering channels, while main-taining a BER of 10^{-8}. For a single interfering channel the pen-alty remains below 1 dB for operation below −30 dBm. The penalty is 2.5 dB when all three interfering channels are op-erating simultaneously at −30 dBm. Measurements of EDFA

gain saturation indicate that the main cause of the crosstalk penalty was homogeneous EDFA saturation.

In conclusion we have fabricated and tested a 4-channel WDM receiver, which operates at 1.2 Gb/s. Receiver sensitivity with optical preamplification is between −39.5 and −32.5 dBm. Simultaneous operation of 4 channels at a BER of 10^{-9} was demonstrated.

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2. C. A. M. Steenbergen et al., "Integrated 1 GHz 4-channel InP phasar based WDM-receiver with Si bipolar frontend array," in Proc. ECOC'95, Sept. 17–21, 1995, Brussels, Belgium.
3. M. R. Amersfoort, Phased-array wavelength demultiplexers and their integration with photodetectors, Ph.D. Thesis, Delft University of Technology, Delft, The Netherlands, 1994, ISBN 90-407-1041-4.

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FC6   9:45 am

Characterization of a variable bit-rate receiver for applications in WDM/WDMA systems

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The protocol transparency provided by WDM and WDMA systems has the advantage of allowing network interfaces (use different protocols at different bit rates) attached to the same network. For optimized performance, the receiver has to be able to adjust to the bit rates dictated by the transmitter. A 20-channel WDM system with quasi-protocol-transparency has been commercialized recently,[1] as each line card of the system is prescribed for a specific protocol at a fixed bit rate. A receiver that is optimized for a specific bit rate can only achieve suboptimal sensitivity at lower bit rates due to excessive thermal noise allowed by the bandwidth of the receiver. Therefore, a receiver optimized for a range of bit rates is desirable for full protocol transparent operations. In order for a receiver to be optimally configured for a range of bit rates, the transimpedance of the preamplifier needs to be tunable. We propose in Ref. 2 to achieve the variable bit-rate capability by tuning the gate voltage of a microFET used as an active feedback resistor in the transimpedance amplifier. Transimpedance amplifiers using active feedback resistor have been described previously, for example, in Ref. 3. Because of their small parasitic capacitance, active feedback resistors can achieve wideband nonintegrating response and stability against ringing and oscillation. Here, we report the characteristics of a receiver whose performance can be optimized for bit rates ranging from 300 to 1,500 Mbps. The receiver is part of an eight-channel receiver array. The other seven receivers use passive feedback resistors in the transimpedance amplifiers.

Our receiver array configuration consists of an optical demultiplexer (such as that reported in Ref. 4) and a detector
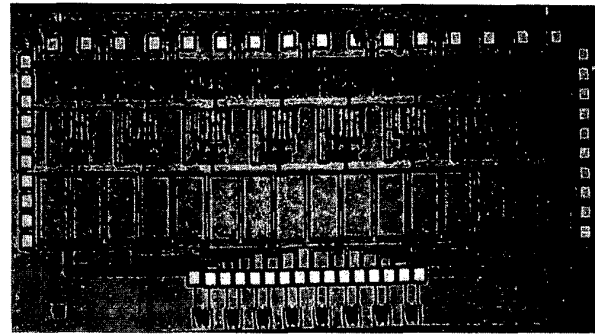
(a)
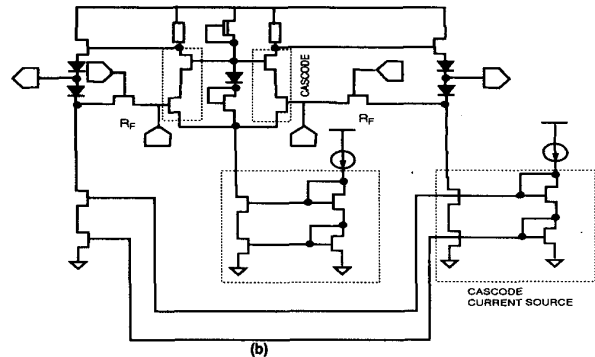
(b)

FC6   Fig. 1. (a) Chip photograph of the 8-channel receiver array. The variable bit-rate receiver is the right-most receiver in the picture (receiver 8), and the left-most receiver being receiver 1. (b) Circuit diagram of receiver 8.

array connected to the transimpedance amplifier array. The optical demultiplexer spatially resolves the input signals and each individual wavelength is then coupled to its corresponding photodetector in the array via total internal reflection at the end face of the demultiplexer. A signalling protocol is assumed to prescribe the bit-rate of each individual wavelength channel and will be discussed in Ref. 2. With the bit-rate information available, the control voltage that alters the receiver bandwidth is generated by a table lookup and a D/A operation. The data in each wavelength channel is then extracted by the timing recovery unit attached to the receiver outputs.

Figure 1 shows the photograph (a) and electronic circuitry (b) of the receiver array. As shown in the figure, each transimpedance amplifier is separated from its neighbor by 560 μm. The contact pads (250-μm pitch) were introduced for hybrid integration with detectors responsive at 1.55-μm range. The additional GaAs metal-semiconductor-metal (MSM) detectors, each separated by 250 μm, were integrated with the receivers to simplify testing. The transimpedance amplifiers utilize a gate length of 1.2 μm with a transconductance g_m of 140 mS/mm, f_T of 15 GHz and combined Cgs (gate-source capacitance) and Cgd (gate-drain capacitance) of 500 fF. A microFET with identical channel width and channel length of 1.2 μm is used as an active feedback resistor whose gate bias can be set externally [receiver 8 in Fig. 1(a)]. Note that because of the differential front-end design, there are AC coupling capacitors of 14.3 pF located at the inputs of the amplifiers. Due to these capacitors, the receiver requires the input data to be line coded by, for example, 8/10 code to eliminate frequency components